

MOSFET – Power, Single, N-Channel, μ8FL

30 V, 71 A, 4.2 m Ω

NVTFS4C06N

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- NVTFS4C06NWF Wettable Flanks Product
- NVT Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Symbol	Param	eter		Value	Unit
V_{DSS}	Drain-to-Source Voltage			30	V
V_{GS}	Gate-to-Source Voltage			±20	V
I _D	Continuous Drain Current	Steady	T _A = 25°C	21	Α
	$R_{\theta JA}$ (Notes 1, 2, 4)	State	T _A = 100°C	15	
P_{D}	Power Dissipation $R_{\theta JA}$		T _A = 25°C	3.1	W
	(Note 1, 2, 4)		T _A = 100°C	1.6	
I _D	Continuous Drain Current		T _A = 25°C	71	
	$R_{\theta JC}$ (Note 1, 3, 4)		T _A = 100°C	50	Α
P_{D}	Power Dissipation		T _A = 25°C	37	W
	$R_{\theta JC}$ (Note 1, 3, 4)		T _A = 100°C	18	
I_{DM}	Pulsed Drain Current	$T_A = 25^{\circ}C$	C, t _p = 10 μs	367	Α
T _J , T _{stg}	Operating Junction and Storage Temperature			–55 to +175	°C
IS	Source Current (Body Diode)			33	Α
E _{AS}	Single Pulse Drain-to-Source Avalanche Energy ($T_J = 25$ °C, $I_L = 26 A_{pk}$, $L = 0.1 \text{ mH}$)			34	mJ
TL	Lead Temperature for Solda (1/8" from Case for 10 s)	ering Purpo	ses	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
30 V	4.2 m Ω @ 10 V	71 A
	6.1 mΩ @ 4.5 V	

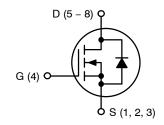


WDFN8 3.3x3.3, 0.65P CASE 511AB

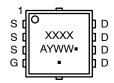


WDFNW8 3.3x3.3, 0.65P (Full-Cut μ8FL WF) CASE 515AN

N-Channel



MARKING DIAGRAM



4C06 = Specific Device Code for

NVMTS4C06N

06WF = Specific Device Code of

NVTFS4C06NWF A = Assembly Location

Y = Year WW = Work Week ■ = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

See detailed ordering, marking and shipping information on page 6 of this data sheet.

NOTE: Some of the devices on this data sheet have been ${\bf DISCONTINUED}.$ Please refer to the table on page 6.

THERMAL RESISTANCE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
$R_{\theta JC}$	Junction-to-Case - Steady State (Drain) (Notes 1 and 4)	4.1	°C/W
$R_{\theta JA}$	Junction-to-Ambient - Steady State (Notes 1 and 2)	48	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

- Surface-mounted on FR4 board using a 650 mm² 2 oz. Cu pad.
 Assumes heat-sink sufficiently large to maintain constant case temperature independent of device power.
 Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

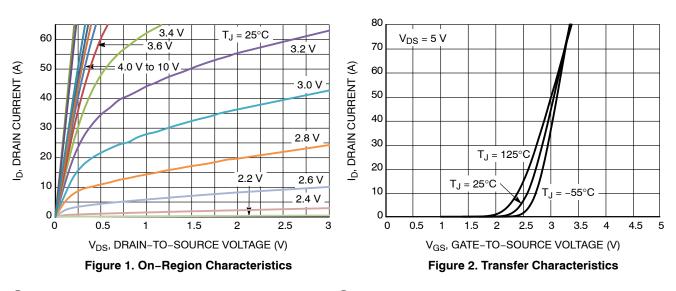
OFF CHARACTERISTICS V _{(RR)DSS} Drain-to-Source Breakdown Voltage Train-to-Source Coefficient V _{GS} = 0 V, I _D = 250 μA 30 - - V I _{DSS} Zero Gate Voltage Drain Current V _{GS} = 0 V, V _{DS} = 24 V T _J = 25°C - - 1.0 μA I _{GSS} Gate - to-Source Leakage Current V _{DS} = 0 V, V _{DS} = 240 V - - 1.0 μA ON CHARACTERISTICS (Note 5) T _J = 125°C - - 1.0 nA V _{GS(TH)} Gate Threshold Voltage V _{GS} = V _{DS} , I _D = 250 μA 1.3 - 2.2 V V _{GS(TH)} Gate Threshold Temperature Coefficient V _{GS} = 10 V I _D = 30 A - 3.4 4.2 mΩ P _{DS(PI)} Drain-to-Source On Resistance V _{GS} = 10 V I _D = 30 A - 3.4 4.2 mΩ P _{SS} (Sign) Forward Transconductance V _{DS} = 15 V, I _D = 15 A - 58 - S R _G Gate Resistance T _A = 25°C - 1.0 <td< th=""><th>Symbol</th><th>Parameter</th><th colspan="2">Test Condition</th><th>Min</th><th>Тур</th><th>Max</th><th>Unit</th></td<>	Symbol	Parameter	Test Condition		Min	Тур	Max	Unit
V _{(SB)(DSS)} Drain-to-Source Breakdown Voltage Temperature Coefficient V _{SS} = 0 V, V _{DS} = 24 V	OFF CHARA	CTERISTICS				•		•
T _J Temperature Coefficient V _{QS} = 0 V, V _{DS} = 24 V T _J = 25°C - - 1.0 µA I _{QSS} Gate - to - Source Leakage Current V _{DS} = 0 V, V _{QS} = ±20 V - - ±100 nA I _{QSS} Gate - to - Source Leakage Current V _{DS} = 0 V, V _{QS} = ±20 V - - ±100 nA ON CHARACTERISTICS (Note 5) V _{QS(TH)} Gate Threshold Voltage V _{QS} = V _{DS} , I _D = 250 µA 1.3 - 2.2 V V _{QS(TH)} Negative Threshold Temperature Coefficient - 3.8 - mV/°C R _{DS(on)} Drain-to-Source On Resistance V _{QS} = 10 V I _D = 30 A - 3.4 4.2 mΩ G _S = 4.5 V I _D = 30 A - 4.9 6.1 mΩ G _S = 4.5 V I _D = 30 A - 4.9 6.1 mΩ G _S = 4.5 V I _D = 30 A - 5.8 - S R _Q Gate Resistance T _A = 25°C - 1.0 - Ω CHARGES AND CAPACITANCES C _{ISS} Input Capacitance V _{QS} = 0 V, f = 1 MHz, V _{DS} = 15 V - 1683 - pF C _{QSS} Output Capacitance V _{QS} = 0 V, V _{DS} = 15 V, f = 1 MHz - 0.023 - C _{RSS} Reverse Transfer Capacitance V _{QS} = 4.5 V, V _{DS} = 15 V, I _D = 30 A - 11.6 - nC Q _{Q(TOT)} Total Gate Charge V _{QS} = 4.5 V, V _{DS} = 15 V, I _D = 30 A - 11.6 - nC Q _{Q(TOT)} Total Gate Charge V _{QS} = 4.5 V, V _{DS} = 15 V, I _D = 30 A - 26 - nC Q _{Q(TOT)} Total Gate Charge V _{QS} = 4.5 V, V _{DS} = 15 V, I _D = 30 A - 26 - nC SWITCHING CHARACTERISTICS (Note 6) V _{QS} = 4.5 V, V _{DS} = 15 V, I _D = 30 A - 26 - nC SWITCHING CHARACTERISTICS (Note 6) V _{QS} = 4.5 V, V _{DS} = 15 V, I _D = 30 A - 3.1 - V - 3.2 - 1.0 - 1.	V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 2	250 μA	30	_	_	V
IGSS	V _{(BR)DSS} / T _J				-	14.4	-	mV/°C
I _{GSS} Gate-to-Source Leakage Current V _{DS} = 0 V, V _{GS} = ±20 V	I _{DSS}	Zero Gate Voltage Drain Current	V _{GS} = 0 V,	T _J = 25°C	_	-	1.0	μΑ
ON CHARACTERISTICS (Note 5) V _{GS(TH)} /T _J Gate Threshold Voltage V _{GS} = V _{DS} , I _D = 250 μA 1.3 - 2.2 V V _{GS(TH)} /T _J Negative Threshold Temperature Coefficient - 3.8 - mV/°C RDS(on) Drain-to-Source On Resistance V _{GS} = 10 V I _D = 30 A - 3.4 4.2 mΩ V _{GS} = 4.5 V I _D = 30 A - 4.9 6.1 mΩ gFS Forward Transconductance V _{DS} = 1.5 V, I _D = 15 A - 58 - S R _G Gate Resistance T _A = 25°C - 1.0 - Ω CHARGES AND CAPACITANCES Ciss Input Capacitance V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V - 1683 - pF C _{ISS} Input Capacitance V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V - 1683 - pF C _{ISS} Reverse Transfer Capacitance V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V, f = 1 MHz - 0.023 - - 16.6 - nC			V _{DS} = 24 V	T _J = 125°C	_	-	10	
$ \begin{array}{ c c c c c c c c } \hline V_{GS(TH)} & Gate Threshold Voltage & V_{GS} = V_{DS}, I_D = 250 \mu \Lambda & 1.3 & - & 2.2 & V \\ \hline V_{GS(TH)}/T_J & Negative Threshold Temperature Coefficient & - & 3.8 & - & mV/^{\circ}C \\ \hline R_{DS(on)} & Drain-to-Source On Resistance & V_{GS} = 10 V & I_D = 30 \Lambda & - & 4.9 & 6.1 \\ \hline W_{GS} & Forward Transconductance & V_{DS} = 1.5 V, I_D = 15 \Lambda & - & 58 & - & S \\ \hline R_G & Gate Resistance & T_A = 25^{\circ}C & - & 1.0 & - & \Omega \\ \hline \hline CHARGES AND CAPACITANCES & & - & 1.0 & - & \Omega \\ \hline CHARGES AND CAPACITANCES & & - & 1683 & - & PF \\ \hline C_{ISS} & Input Capacitance & V_{GS} = 0 V, f = 1 \text{MHz}, V_{DS} = 15 V & - & 1683 & - & PF \\ \hline C_{RSS} & Reverse Transfer Capacitance & & - & 40 & - & - & - & 40 & - \\ \hline C_{RSS} & Reverse Transfer Capacitance & & V_{GS} = 0 V, V_{DS} = 15 V, f = 1 \text{MHz} & - & 0.023 & - & - & - & - & - & - & - & - \\ \hline Q_{G(TOT)} & Total Gate Charge & V_{GS} = 4.5 V, V_{DS} = 15 V, I_D = 30 \Lambda & - & 11.6 & - & - & - & - & - & - & - & - & - & $	I_{GSS}	Gate-to-Source Leakage Current	V _{DS} = 0 V, V _{GS} = ±20 V		-	-	±100	nA
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	ON CHARAC	CTERISTICS (Note 5)						
Ros(on) Drain-to-Source On Resistance V _{GS} = 10 V I _D = 30 A - 3.4 4.2 MΩ	V _{GS(TH)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 1$	250 μΑ	1.3	-	2.2	V
V _{GS} = 4.5 V I _D = 30 A - 4.9 6.1	V _{GS(TH)} /T _J	Negative Threshold Temperature Coefficient			-	3.8	-	mV/°C
Forward Transconductance VDS = 1.5 V, ID = 15 A - 58 - S RG Gate Resistance TA = 25°C - 1.0 - Ω CHARGES AND CAPACITANCES CISS Input Capacitance VGS = 0 V, f = 1 MHz, VDS = 15 V - 1683 -	R _{DS(on)}	Drain-to-Source On Resistance	V _{GS} = 10 V	I _D = 30 A	-	3.4	4.2	mΩ
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$			V _{GS} = 4.5 V	I _D = 30 A	-	4.9	6.1	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	9FS	Forward Transconductance	V _{DS} = 1.5 V, I _D =	15 A	_	58	-	S
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	R _G	Gate Resistance	T _A = 25°C		-	1.0	-	Ω
Coss Coss Output Capacitance — 841 — 40 — 40 — 40 — 40 — 40 — 40 — 40 —	CHARGES A	AND CAPACITANCES						
CRSS Reverse Transfer Capacitance - 40 - CRSS/CISS Capacitance Ratio V _{GS} = 0 V, V _{DS} = 15 V, f = 1 MHz - 0.023 - QG(TOT) Total Gate Charge V _{GS} = 4.5 V, V _{DS} = 15 V; I _D = 30 A - 11.6 - nC QG(TH) Threshold Gate Charge V _{GS} = 4.5 V, V _{DS} = 15 V; I _D = 30 A - 11.6 - nC QGB Gate-to-Drain Charge - 4.0 - - 4.7 - - V VGP Gate Plateau Voltage V _{GS} = 10 V, V _{DS} = 15 V; I _D = 30 A - 26 - nC SWITCHING CHARACTERISTICS (Note 6) td(ON) Turn-On Delay Time V _{GS} = 4.5 V, V _{DS} = 15 V, I _D = 30 A - 26 - nC SWITCHING CHARACTERISTICS (Note 6) V _{GS} = 10 V, V _{DS} = 15 V, I _D = 30 A - 26 - nC tq(ON) Turn-On Delay Time V _{GS} = 10 V, V _{DS} = 15 V, I _D = 15 V, I _D = 15 A, R _G = 3.0 Ω - 10 - 8.0 - nS tq(OFF) <td>C_{ISS}</td> <td>Input Capacitance</td> <td colspan="2" rowspan="2">V_{GS} = 0 V, f = 1 MHz, V_{DS} = 15 V</td> <td>_</td> <td>1683</td> <td>-</td> <td>pF</td>	C _{ISS}	Input Capacitance	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V		_	1683	-	pF
CRSS/CISS Capacitance Ratio V _{GS} = 0 V, V _{DS} = 15 V, f = 1 MHz - 0.023 - Q _{G(TOT)} Total Gate Charge V _{GS} = 4.5 V, V _{DS} = 15 V; I _D = 30 A - 11.6 - nC Q _{G(TH)} Threshold Gate Charge - 4.7 - - - 4.7 - <td< td=""><td>C_{OSS}</td><td>Output Capacitance</td><td>_</td><td>841</td><td>-</td><td></td></td<>	C _{OSS}	Output Capacitance			_	841	-	
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	C _{RSS}	Reverse Transfer Capacitance			_	40	-	
Q _{G(TH)} Threshold Gate Charge - 2.6 - Q _{GS} Gate-to-Source Charge - 4.7 - Q _{GD} Gate-to-Drain Charge - 4.0 - V _{GP} Gate Plateau Voltage - 3.1 - V Q _{G(TOT)} Total Gate Charge V _{GS} = 10 V, V _{DS} = 15 V; I _D = 30 A - 26 - nC SWITCHING CHARACTERISTICS (Note 6) t _{d(ON)} Turn-On Delay Time V _{GS} = 4.5 V, V _{DS} = 15 V, I _D = 15 V, I _D = 15 A, R _G = 3.0 Ω - 10 - ns t _d (OFF) Turn-Off Delay Time V _{GS} = 4.5 V, V _{DS} = 15 V, I _D = 15 A, R _G = 3.0 Ω - - 8.0 - ns t _d (OFF) Turn-Off Delay Time V _{GS} = 10 V, V _{DS} = 15 V, I _D = 15 V, I _D = 15 A, R _G = 3.0 Ω - - 28 - t _d (OFF) Turn-Off Delay Time - - - - - - - - - - - - - -	C _{RSS} /C _{ISS}	Capacitance Ratio	V _{GS} = 0 V, V _{DS} = 15 V, f = 1 MHz		-	0.023	-	
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	Q _{G(TOT)}	Total Gate Charge	$V_{GS} = 4.5 \text{ V}, V_{DS}$	_S = 15 V; I _D = 30 A	_	11.6	-	nC
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	Q _{G(TH)}	Threshold Gate Charge			_	2.6	-	
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	Q _{GS}	Gate-to-Source Charge			_	4.7	-	
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	Q_{GD}	Gate-to-Drain Charge			_	4.0	-	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	V _{GP}	Gate Plateau Voltage			_	3.1	_	V
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Q _{G(TOT)}	Total Gate Charge	V _{GS} = 10 V, V _{DS}	= 15 V; I _D = 30 A	-	26	_	nC
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	SWITCHING	CHARACTERISTICS (Note 6)			•	•		•
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	t _{d(ON)}	Turn-On Delay Time			_	10	_	ns
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$		Rise Time	I_D = 15 A, R_G = 3.0 Ω		_	32	-	1
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	t _{d(OFF)}	Turn-Off Delay Time			_	18	-	
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$		Fall Time			_	5.0	_	
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	t _{d(ON)}	Turn-On Delay Time			_	8.0	-	ns
		Rise Time	$I_D = 15 A, R_G = 3$	3.0 Ω	_	28	-	
	t _{d(OFF)}	Turn-Off Delay Time			_	24	-	
		•			_	3.0	-	

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified) (continued)

Symbol	Parameter	Test Co	Test Condition		Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS							
V_{SD}	Forward Diode Voltage	V _{GS} = 0 V, I _S = 10 A	T _J = 25°C	-	0.8	1.1	V
		IS = 10 A	$T_{J} = 10 \text{ A}$	-	0.63	_	
t _{RR}	Reverse Recovery Time	V _{GS} = 0 V, dIS/dt	$V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 30 \text{ A}$		34	_	ns
ta	Charge Time	I _S = 30 A			17	-	
t _b	Discharge Time				17	_	
Q _{RR}	Reverse Recovery Charge			_	22	_	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$. 6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



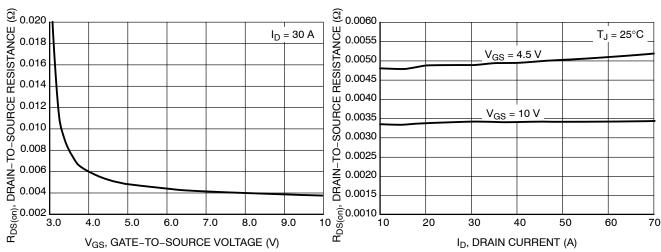


Figure 3. On-Resistance vs. V_{GS}

Figure 4. On-Resistance vs. Drain Current and **Gate Voltage**

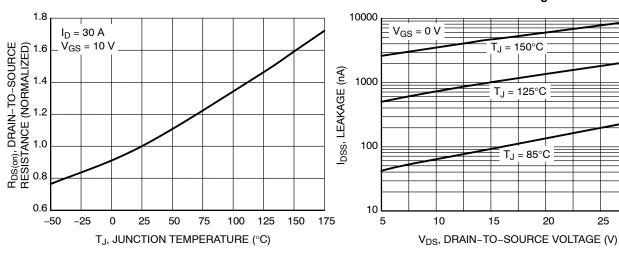


Figure 5. On-Resistance Variation with **Temperature**

Figure 6. Drain-to-Source Leakage Current vs. Voltage

25

30

TYPICAL CHARACTERISTICS (continued)

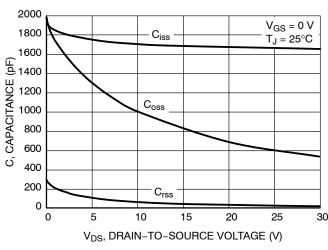


Figure 7. Capacitance Variation

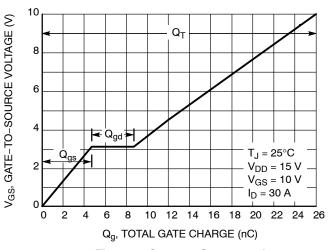


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

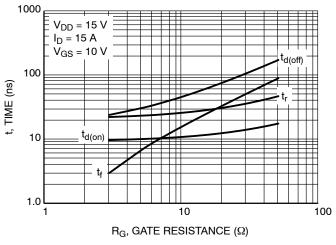


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

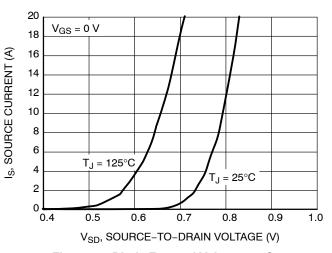


Figure 10. Diode Forward Voltage vs. Current

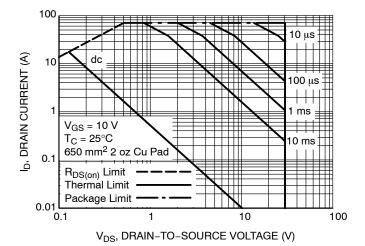


Figure 11. Maximum Rated Forward Biased Safe Operating Area

TYPICAL CHARACTERISTICS (continued)

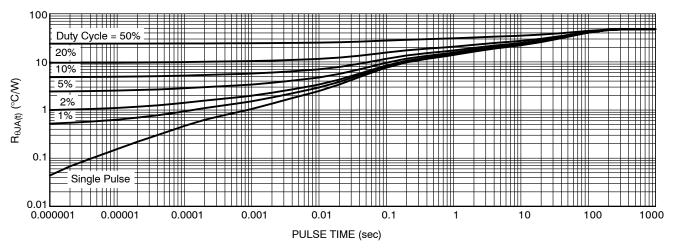


Figure 12. Thermal Response

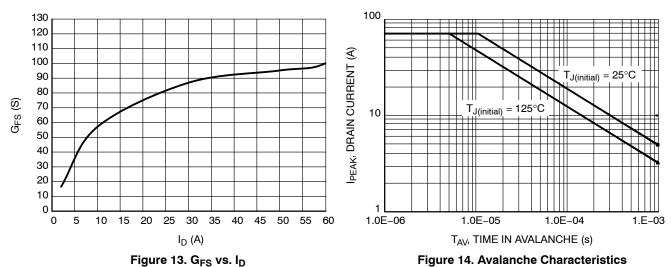


Figure 14. Avalanche Characteristics

ORDERING INFORMATION

Device	Package	Shipping [†]
NVTFS4C06NTAG	WDFN8 3.3x3.3, 0.65P (Pb-Free)	1500 / Tape & Reel
NVTFS4C06NTWG	WDFN8 3.3x3.3, 0.65P (Pb-Free)	5000 / Tape & Reel

DISCONTINUED (Note 7)

NVTFS4C06NWFTAG	WDFNW8 3.3x3.3, 0.65P (Full-Cut μ8FL WF) (Pb-Free)	1500 / Tape & Reel
NVTFS4C06NWFTWG	WDFNW8 3.3x3.3, 0.65P (Full-Cut μ8FL WF) (Pb-Free)	5000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

^{7.} DISCONTINUED: These devices are not recommended for new design. Please contact your onsemi representative for information. The most current information on these devices may be available on www.onsemi.com.



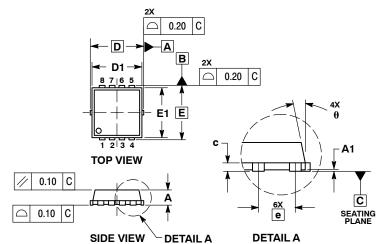




SCALE 2:1

WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

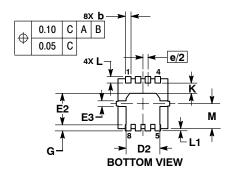
DATE 23 APR 2012



NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
 PROTRUSIONS OR GATE BURRS.

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00		0.05	0.000		0.002	
b	0.23	0.30	0.40	0.009	0.012	0.016	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D		3.30 BSC		C	.130 BSC)	
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
Е		3.30 BSC		C	.130 BSC)	
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	0.23	0.30	0.40	0.009	0.012	0.016	
е		0.65 BSC	;	Ú	0.026 BS	2	
G	0.30	0.41	0.51	0.012	0.016	0.020	
K	0.65	0.80	0.95	0.026	0.032	0.037	
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
M	1.40	1.50	1.60	0.055	0.059	0.063	
θ	0 °		12 °	0 °		12 °	

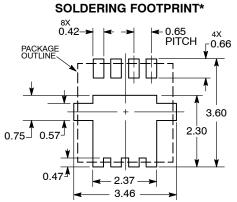


GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code Α = Assembly Location

= Year WW = Work Week = Pb-Free Package



DIMENSION: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

DOCUMENT NUMBER:	98AON30561E	Electronic versions are uncontrolled except when accessed directly from the Docume Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in re-		
DESCRIPTION:	WDFN8 3.3X3.3, 0.65P		PAGE 1 OF 1	

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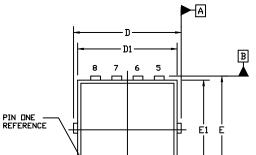
^{*}This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.



WDFNW8 3.3x3.3, 0.65P (Full-Cut μ8FL WF)

CASE 515AN **ISSUE O**

DATE 25 AUG 2020

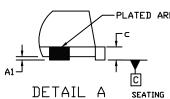


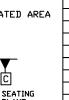
3

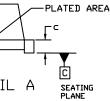
TOP VIEW



- 1. DIMENSIONING AND TOLERANCING PERASME Y14.5M. 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- DIMENSION DI AND EI DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

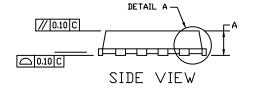




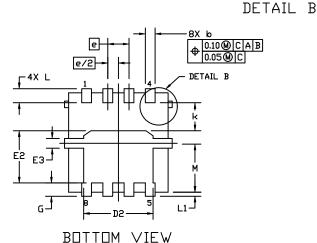


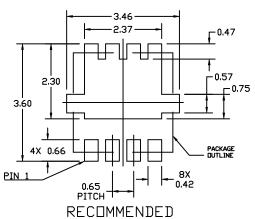


	MILLIMETERS				
DIM	MIN.	NDM.	MAX.		
Α	0.70	0.75	0.80		
A1	0.00		0.05		
b	0.23	0.30	0.40		
С	0.15	0.20	0.25		
D	3.05	3.30	3.55		
D1	2.95	3.05	3.15		
D2	1.98	2.11	2.24		
E	3.05	3.30	3.55		
E1	2.95	3.05	3.15		
E2	1.47	1.60	1.73		
E3	0.23	0.30	0.40		
e		0.65 BSC			
G	0.30	0.41	0.51		
K	0.65	0.80	0.95		
L	0.30	0.43	0.59		
L1	0.06	0.13	0.20		
М	1.40	1.50	1.60		









MOUNTING FOOTPRINT For additional information on our Pb-Free strategy and soldering details, please download the DN Semiconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

GENERIC MARKING DIAGRAM*

XXXX AYWW= XXXX = Specific Device Code

= Assembly Location

= Year WW = Work Week = Pb-Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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